

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HELD ET AL.	
		10/058,320	Examiner	Art Unit 2621

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,278,491 B1	08-2001	Wang et al.	348/370
*	B	US-6,285,410 B1	09-2001	Marni, Sandrine	348/576
*	C	US-6,009,209	12-1999	Acker et al.	382/275
*	D	US-6,728,401 B1	04-2004	Hardeberg, Jon Y.	382/167
*	E	US-5,130,789	07-1992	Dobbs et al.	358/500
*	F	US-6,690,822 B1	02-2004	Chen et al.	382/162
*	G	US-6,614,995 B2	09-2003	Tseng, Li-Wen	396/61
*	H	US-6,577,751 B2	06-2003	Yamamoto, Hiroyasu	382/117
*	I	US-6,016,354	01-2000	Lin et al.	382/117
*	J	US-6,798,903 B2	09-2004	Takaoka, Naoki	382/167
*	K	US-6,718,051 B1	04-2004	Eschbach, Reiner	382/117
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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